

Notice of References Cited	Application/Control No. 10/563,423	Applicant(s)/Patent Under Reexamination SHINKAWA ET AL.	
	Examiner Nicholas P. D'Aniello	Art Unit 4111	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP62-21112	01-1987	JAPAN	FUNAKI ET AL.	
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NON-PATENT DOCUMENTS

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